## Notice of References Cited Application/Control No. 10/750,217 Examiner NEAL R. SEREBOFF Applicant(s)/Patent Under Reexamination CYR ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0095314 A1	07-2002	Bodsworth et al.	705/2
*	В	US-2002/0143692 A1	10-2002	Heimermann et al.	705/37
*	С	US-2003/0149578 A1	08-2003	Wong, Yek-Meng	705/1
*	D	US-7,110,976 B2	09-2006	Heimermann et al.	705/37
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	C						
	>						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.